

STGD3NB60S

N-CHANNEL 3A - 600V DPAK Power MESHTM IGBT

PRELIMINARY DATA

TYPE	V _{CES}	V _{CE(sat)}	I _C
STGD3NB60S	600 V	< 1.5 V	3 A

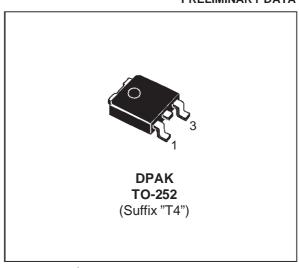
- HIGH INPUT IMPEDANCE (VOLTAGE DRIVEN)
- VERY LOW ON-VOLTAGE DROP (Vcesat)
- HIGH CURRENT CAPABILITY
- OFF LOSSES INCLUDE TAIL CURRENT
- SURFACE-MOUNTING DPAK (TO-252) POWER PACKAGE IN TAPE & REEL (SUFFIX "T4")

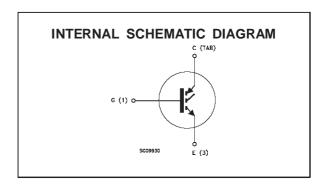
DESCRIPTION

Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESHTM IGBTs, with outstanding perfomances. The suffix "S" identifies a family optimized to achieve minimum on-voltage drop for low frequency applications (<1kHz).

APPLICATIONS

- LIGHT DIMMER
- STATIC RELAYS
- MOTOR CONTROL





ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V _{CES}	Collector-Emitter Voltage (V _{GS} = 0)	600	V
V _{ECR}	Reverse Battery Protection	20	V
V_{GE}	Gate-Emitter Voltage	± 20	V
Ic	Collector Current (continuous) at T _c = 25 °C	6	А
Ic	Collector Current (continuous) at T _c = 100 °C	3	А
I _{CM} (•)	Collector Current (pulsed)	24	А
P _{tot}	Total Dissipation at T _c = 25 °C	40	W
	Derating Factor	0.32	W/°C
T _{stg}	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

(•) Pulse width limited by safe operating area

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THERMAL DATA

ſ	,			Junction-case	Max	3.125	°C/W
-	$R_{thj-amb}$	Thermal	Resistance	Junction-ambient	Max	100	°C/W
	$R_{thc\text{-sink}}$	Thermal	Resistance	Case-sink	Тур	1.5	°C/W

ELECTRICAL CHARACTERISTICS ($T_j = 25$ $^{\circ}C$ unless otherwise specified)

OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{BR(CES)}	Collector-Emitter Breakdown Voltage	$I_C = 250 \ \mu A$ $V_{GE} = 0$	600			V
I _{CES}	Collector cut-off (V _{GE} = 0)	$V_{CE} = Max Rating$ $T_j = 25 ^{\circ}C$ $V_{CE} = Max Rating$ $T_j = 125 ^{\circ}C$			10 100	μΑ μΑ
I _{GES}	Gate-Emitter Leakage Current (V _{CE} = 0)	$V_{GE} = \pm 20 \text{ V}$ $V_{CE} = 0$			± 100	nA

ON (*)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{GE(th)}	Gate Threshold Voltage	$V_{CE} = V_{GE}$ $I_C = 250 \mu A$	2.5		5	V
V _{CE} (SAT)	Collector-Emitter Saturation Voltage	V _{GE} = 15 V I _C = 3 A V _{GE} = 15 V I _C = 1 A		1.2 1	1.5	V V

DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
G fs	Forward Transconductance	V _{CE} =25 V I _C = 3 A	1.7	2.5		S
C _{ies} C _{oes} C _{res}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	V _{CE} = 25 V f = 1 MHz V _{GE} = 0		255 30 5.6		pF pF pF
Q _G Q _{GE} Q _{GC}	Total Gate Charge Gate-Emitter Charge Gate-Collector Charge	V _{CE} = 480 V I _C = 3 A V _{GE} = 15 V		18 5.4 5.5		nC nC nC
I _{CL}	Latching Current	$V_{clamp} = 480 \text{ V} R_G=1 \text{k}\Omega$ $T_j = 150 \text{ °C}$	12			А

SWITCHING ON

Symbol	Parameter	Test Conditions			Тур.	Max.	Unit
t _{d(on)}	Delay Time Rise Time	V _{CC} = 480 V V _{GE} = 15 V	$I_C = 3 A$ $R_G = 1k\Omega$		170 540		ns ns
(di/dt) _{on}	Turn-on Current Slope	$V_{CC} = 480 \text{ V}$ $R_G = 1 \text{k}\Omega$	$I_C = 3 A$ $V_{GE} = 15 V$		30		A/μs
Eon	Turn-on Switching Losses	T _j = 125 °C			300		μJ

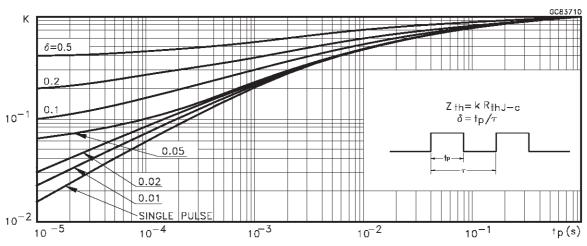
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ELECTRICAL CHARACTERISTICS (continued)

SWITCHING OFF

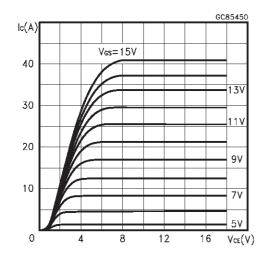
Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
tc	Cross-Over Time	V _{CC} = 480 V	I _C = 3 A		1.8		μs
$t_r(v_{off})$	Off Voltage Rise Time	$R_{GE} = 1 k\Omega$	$V_{GE} = 15 V$		1.0		μs
$t_d(off)$	Delay Time				3.4		μs
t_f	Fall Time				0.72		μs
E _{off} (**)	Turn-off Switching Loss				1.15		mJ
tc	Cross-Over Time	V _{CC} = 480 V	I _C = 3 A		2.8		μs
$t_r(v_{off})$	Off Voltage Rise Time	$R_{GE} = 10 \Omega$	$V_{GE} = 15 V$		1.45		μs
$t_d(off)$	Delay Time	T _i = 125 °C			3.6		μs
t _f	Fall Time				1.2		μs
E _{off} (**)	Turn-off Switching Loss				1.8		mJ

Thermal Impedance

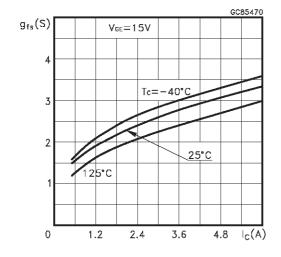


⁽e) Pulse width limited by max. junction temperature
(*) Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %
(**)Losses Include Also The Tail (Jedec Standardization)

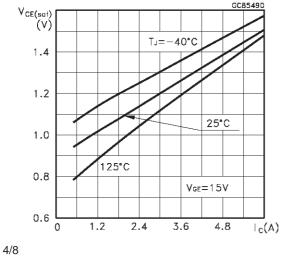
Output Characteristics



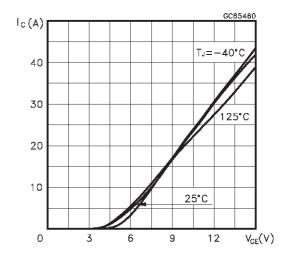
Transconductance



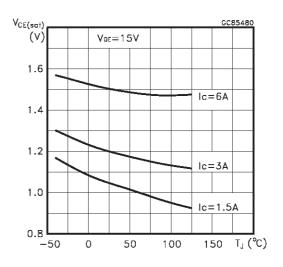
Collector-Emitter On Voltage vs Collector Current



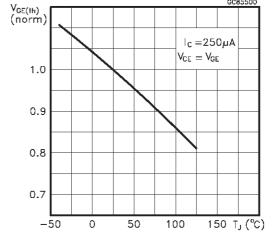
Transfer Characteristics



Collector-Emitter On Voltage vs Temperature

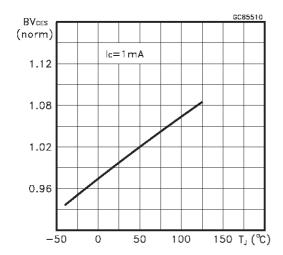


Gate Threshold vs Temperature

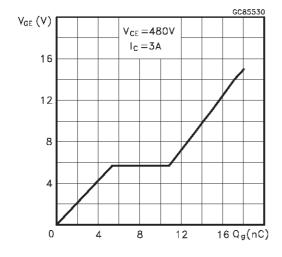


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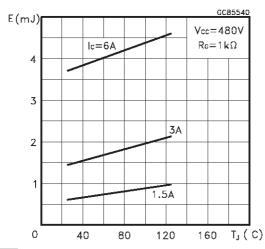
Normalized Breakdown Voltage vs Temperature



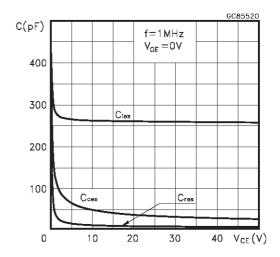
Gate Charge vs Gate-Emitter Voltage



Total Switching Losses vs Temperature

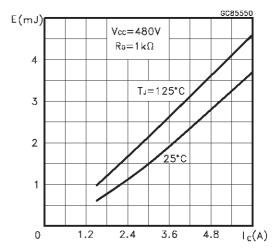


Capacitance Variations



Total Switching Losses vs Gate Resistance

Total Switching Losses vs Collector Current



 \overline{A}

Switching Off Safe Operatin Area

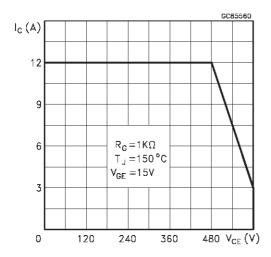


Fig. 1: Gate Charge test Circuit

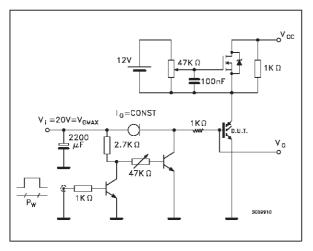


Fig. 2: Test Circuit For Inductive Load Switching

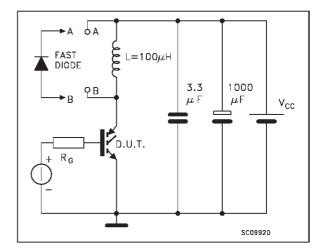
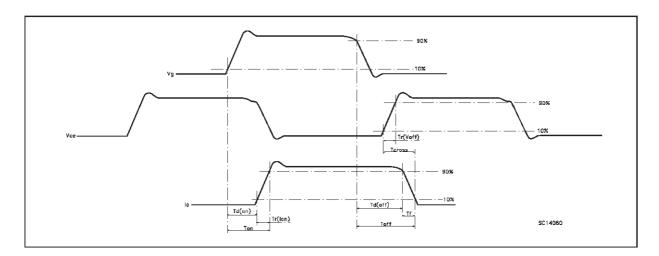


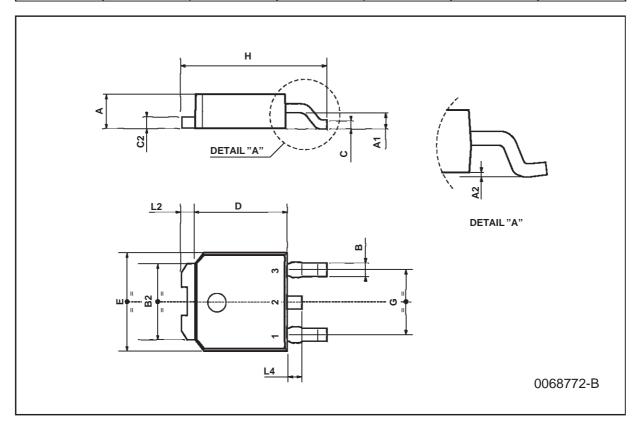
Fig. 3: Switching Waveforms



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TO-252 (DPAK) MECHANICAL DATA

DIM.		mm		inch			
Diwi.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
А	2.2		2.4	0.086		0.094	
A1	0.9		1.1	0.035		0.043	
A2	0.03		0.23	0.001		0.009	
В	0.64		0.9	0.025		0.035	
B2	5.2		5.4	0.204		0.212	
С	0.45		0.6	0.017		0.023	
C2	0.48		0.6	0.019		0.023	
D	6		6.2	0.236		0.244	
E	6.4		6.6	0.252		0.260	
G	4.4		4.6	0.173		0.181	
Н	9.35		10.1	0.368		0.397	
L2		0.8			0.031		
L4	0.6		1	0.023		0.039	



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